

Low-temperature solution-processed Zn-doped SnO₂ photoanodes: enhancements in charge collection efficiency and mobility†

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An increase in charge collection efficiency and charge mobility from 78 to 89% and 0.02 to 0.04 cm² V⁻¹ s⁻¹, respectively, in low-temperature solution-processed Zn-doped SnO₂ photoanodes resulted in a two-fold enhancement in power conversion efficiency (PCE) as compared to Zn free SnO₂ photoanodes in dye-sensitized solar cells (DSSCs).

DSSCs have attracted immense interest as promising candidates for the future development of commercially viable solar cells.^{1–3} Nanocrystalline TiO₂, ZnO, Nb₂O₅, WO₃ and SnO₂ have widely been envisaged as photoanodes for developing a high performance DSSC to obtain a balance between cost and ease of fabrication, compared with Si-based solar cells.⁴ As a DSSC photoanode, TiO₂ has been a dominant material that consistently exhibits PCE as high as ~12%.⁵ Analogous to TiO₂, ZnO has also been explored largely due to its similar band gap energy ($E_g = 3.2$ eV) and electronic energy levels. While the high electron mobility (μ) of ZnO (>200 cm² V⁻¹ s⁻¹) is certainly an advantage, its instability in acidic dyes restricts the electron injection rate from the sensitizer (dye) to ZnO by forming an insulating surface agglomerative layer.⁶ Another chemically stable alternative, SnO₂ also possesses relatively high μ (~100–200 cm² V⁻¹ s⁻¹) as compared to TiO₂ (~10⁻² cm² V⁻¹ s⁻¹).⁷

However, one major disadvantage with SnO₂-based DSSC is its tendency to exhibit a relatively low open circuit voltage (V_{oc}). This is due to its 300 mV positively located conduction band level.⁸ The inferior photovoltaic properties of SnO₂ are additionally attributed to faster electron recombination kinetics and the poor dye uptake associated with the low isoelectric point.⁹ Grätzel *et al.*¹⁰ demonstrated a significant improvement in photovoltaic parameters by covering the mesoporous SnO₂ with a thin shell of ZnO. Nevertheless, this chemically unstable component (ZnO) in the composite is a challenging issue that needs to be resolved. Previously, we reported that employing dual photosensitization can effectively suppress the agglomeration of ZnO nanoparticles.¹¹ Thus, the most significant challenge is to complement the advantages of the present photoanode materials to construct a compound structure that is chemically stable and possesses higher charge collection kinetics for efficient PCE in DSSCs. In this context, the chemically stable Zn-doped SnO₂ can be a good alternative since the effective ionic radius of Zn²⁺ (74 pm) is close to that of Sn⁴⁺ (69 pm), and thus, it is expected that Zn²⁺ ions can easily be incorporated into the lattice of SnO₂ to offer fascinating electronic properties collectively. Moreover, the Zn-doped films exhibit an elevated electron Fermi level, which may enhance band bending to lower the density of empty trap states.¹²

In this communication, we present a remarkable 2 fold enhancement in the photovoltaic performance of DSSCs containing chemically synthesized upright-standing Zn-doped SnO₂ nanoplates as photoanodes that exhibit high charge collection efficiency and dramatically reduced charge transport resistance as compared to Zn-free SnO₂ photoanodes with an impressive overall PCE of 4.87%. The obtained PCE is by far the highest for low temperature chemically synthesized SnO₂-based DSSCs.¹³ This work is in continuation of our research focusing on the low temperature chemical synthesis of DSSC photoanodes.¹⁴ A low temperature chemical synthesis route is extremely advantageous as it paves opportunities for facile and commercially viable scalable synthesis. Various Zn-doped SnO₂ photoanodes were synthesized using a simple chemical bath

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deposition method at 70 °C and termed as A–E with increasing Zn-doping concentration at successive intervals of 1 wt% starting from 0 wt% for A and 4 wt% Zn-doping for photoanode E. The detailed synthesis procedure (with elemental mapping) is presented in ESI† (Table 1). The XRD spectra (Fig. 1) of all photoanodes confirm the tetragonal rutile structure of SnO₂ (file: 41-1445).

For Zn-doped SnO₂ photoanodes, no other crystalline phase and peaks of impurities were detected (Fig. 1, spectra A–E), indicating the formation of neither separate SnO₂/ZnO nor a Zn_xSn_{1-x}O₂ composite structure. To investigate the effect of Zn²⁺ ion doping on the crystallinity of SnO₂, (110), (200), and (211) diffraction peaks are monitored. Spectra (B–E) of Fig. 1 reveal that with an increase of Zn wt%, the 2θ values shift by 0.17°, 0.244° and 0.144°, respectively, as compared to those of pristine SnO₂. This clearly proves that Zn²⁺ ion incorporation has led to a lattice deformation in the Zn-doped SnO₂. Moreover, upon Zn-doping, the photoelectron peaks for Sn 3d_{5/2} and Sn 3d_{3/2} in the X-ray photoelectron spectroscopy (XPS) spectra (Fig. S2b, ESI†) appear to have decreased from 487.96 eV to 486.02 eV and 497 eV to 494.97 eV, respectively. The O 1s transition peak (Fig. S2c, ESI†) is shifted towards the lower binding energy by 2.01 eV from 531.98 eV to 529.97 eV. Also, the strong Zn 2p_{3/2} peak (Fig. S2d, ESI†) at the binding energy of 1056 eV further confirms the presence of Zn in the SnO₂ matrix.

The FE-SEM images of pristine and 0–4 wt% Zn-doped SnO₂ photoanodes (Fig. 2) reveal a clear change in the parent surface morphology after Zn-doping. The width of an individual pristine nanosheet was found to be 15–20 nm; it increased to 30–60 nm for Zn-doping of 0–4 wt%. This suggests that Zn-doping leads to a significant change in the morphology of the parent nanostructure (Fig. 2a), with a distinct change in roughness with increasing Zn concentration (Fig. 2b–d). It is expected that the newly formed rough structures must aid in superior dye adsorption. This interconnected network of nanoplates should offer mechanical strength along with rapid electron transport pathways due to the minimized grain boundaries. With a further increase in Zn concentration of more than 3 wt%, the nanoplates tend to bend. This may be due to the lower mechanical strength of the upright standing SnO₂ nanoplates developed due to the breaking of bonds after excessive Zn incorporation.

Fig. 3a shows the *J*–*V* characteristics of DSSCs (fabricated as per the structure depicted in Fig. 3a) for pristine and Zn-doped

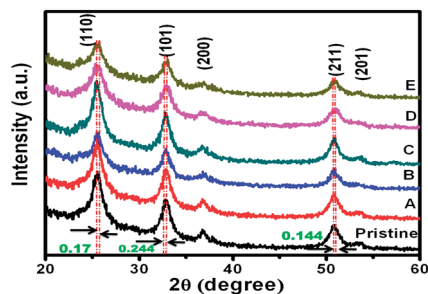


Fig. 1 XRD spectra of pristine and Zn-doped SnO₂ nanoplates.

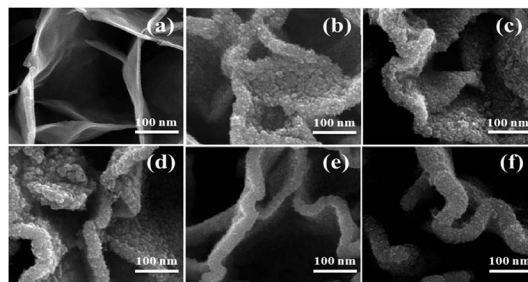


Fig. 2 FE-SEM images of (a) pristine SnO₂, (b) after TiCl₄ surface treatment, and (c–f) 1–4 wt% Zn-doped SnO₂ photoanodes.

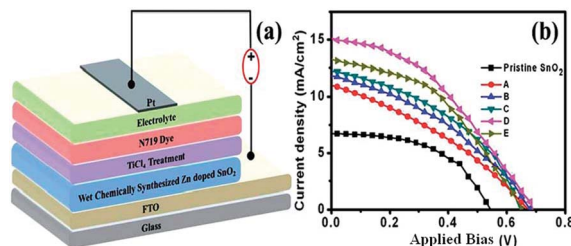


Fig. 3 (a) Device structure and (b) *J*–*V* curves of all DSSCs under 1 sun illumination.

SnO₂ photoanodes. It is observed that the Zn doping of SnO₂ has a significant impact on DSSC performance. The detailed photovoltaic parameters are summarized in Table 2 (ESI†). DSSCs comprising a pristine SnO₂ photoanode exhibited a short-circuit current density (*J*_{sc}) of 6.73 mA cm⁻², *V*_{oc} of 0.55 V and a fill factor (*ff*) of 0.51, which itself is an improvement from our previously reported PCE of 0.37% for a pristine SnO₂ photoanode sensitized with dye.^{13b} However, PCE increased to 2.54% after TiCl₄ treatment because of the pronounced increase in *J*_{sc} and *V*_{oc} although *ff* dropped. This is attributed to the increase in roughness induced by the TiCl₄ treatment that eventually increased the uptake of dye and decreased the electron/electrolyte recombination.¹⁵

In DSSCs of Zn-doped SnO₂ photoanodes, an exponential increase in photovoltaic performance with a Zn doping level of up to 3 wt% is observed. A maximum PCE of 4.87% is achieved for DSSCs having 3 wt% of Zn-doped SnO₂ photoanode, which is about two times higher than that of DSSCs of pristine SnO₂ photoanodes. The increased photovoltaic performance is majorly due to the enhancement in *J*_{sc}. This is attributed to the enhanced charge-generation efficiency; suppressed electron recombination (explained later using EIS analyses), and higher dye loading, as compared to pristine SnO₂ photoanodes.¹⁶ For comparison, PEC results of SnO₂ photoanodes synthesized using other methods are given in Table 3 of ESI.† The incident photon-to-electron conversion efficiencies (IPCE) of pristine and Zn-doped SnO₂ photoanodes are shown in Fig. S5, ESI.† A considerable change in IPCE measurements after TiCl₄ treatment is obtained, which in fact, is significantly less than that in the case of the wet chemically synthesized SnO₂–TiCl₄.^{13b} However, with the Zn-doping, IPCE values and the wavelength

range are substantially increased. The IPCE value is increased from 30% to 56% (nearly double), which can be attributed to the Zn-doping effect, consistent with J - V measurements. A decrease in IPCE at a higher Zn-doping level is due to the negative mass/agglomeration effect of ZnO with SnO₂.¹⁷

A UV-vis spectroscopy investigation, as shown in Fig. S4 (ESI†), revealed a proportionally higher increase in the optical density at higher wavelengths, strongly indicating increased dye loading after Zn-doping. The dye-loading experiments revealed that the dye loading amounts are increased by 152 and 350%, respectively, for pristine and 3 wt% Zn-doped SnO₂. The suppressed electron recombination is evident from the J - V spectra of DSSCs measured under a forward bias potential in the dark, as shown in Fig. S3 (ESI†). The dark current onset of a pristine SnO₂ photoanode occurred at a low forward bias, indicating faster electron-recombination kinetics.¹⁸ In order to analyze the electron transport behavior in the DSSCs, electrochemical impedance spectroscopy (EIS) measurements were performed, which distinguished the charge transport resistance (R_{ct}) from the chemical capacitance of the device.

The equivalent circuit used for EIS measurements and EIS data with electronic parameters are presented in Fig. S6 and Table 4 (ESI†). The Nyquist plots shown in Fig. 4a measured under 1 sun conditions for all DSSCs at the respective V_{oc} conditions clearly reveal lower R_{ct} for the 3 wt% Zn-doped SnO₂ photoanode, resulting due to the reduction of trap states for photogenerated electrons. The EIS measurements revealed higher μ for Zn-doped photoanodes than that of the pristine photoanode, indicating favorable electron transport through a longer distance with less diffusive hindrance after Zn-doping. The variation of diffusion length (L_n) and μ with respect to Zn doping is presented in Fig. 4b. A further increase in the Zn²⁺ ion concentration above 3 wt% in the solution starts deceleration in the L_n value. This is accomplished with a significant increase in the number of bond deformations and the generation of more trap states within the photoanode.¹⁹ The increasing trend of the μ value (Table 4, ESI†) with Zn intercalation in the SnO₂ matrix is clearly noticed (from 0.022 cm² V⁻¹ s⁻¹ to 0.04 cm² V⁻¹ s⁻¹ for pristine and 3 wt% Zn-doped SnO₂ photoanodes, respectively). Zn-doping also resulted in a decrease in the electron transit

time (τ_d) (Fig. 4c) from 0.01 to 0.06 s for the pristine and the 3 wt% Zn-doped SnO₂ photoanodes, respectively. The decrease in τ_d proved the minimization of the trapping states, facilitating the effective transport of photogenerated electrons. The mean electron lifetime (τ_n) calculated in all DSSCs using EIS is presented in Table 4, ESI† Fig. 4d represents the plot of variation of τ_n and PCE of the DSSCs with varying Zn-doping concentrations. The τ_n of the doped photoanode is smaller than that for the undoped photoanode. However, with Zn-doping, the τ_n values are nearly one order of magnitude greater than the corresponding τ_d values, justifying that Zn-doping can minimize the trapping–detrapping processes. The charge collection efficiency (η_{cc}) is found to increase from 78.45% to 89.32% for the undoped and the 3 wt% Zn-doped SnO₂ photoanodes. With a further increase in the Zn-doping, η_{cc} is reduced to 84.76% and τ_d is increased to 0.06 s.

In summary, a low-temperature (70 °C) wet chemical solution method was carried out for the synthesis of Zn-doped SnO₂ photoanodes. DSSCs fabricated with the photoanodes of optimized Zn-doping (3 wt%) exhibited an overall PCE of 4.87% and IPCE of 56%, which is two-fold order higher than the undoped SnO₂ photoanodes. The shortening of the electron transit time after Zn-doping and increased charge collection efficiency proved to be advantageous for the high performance obtained in this work.

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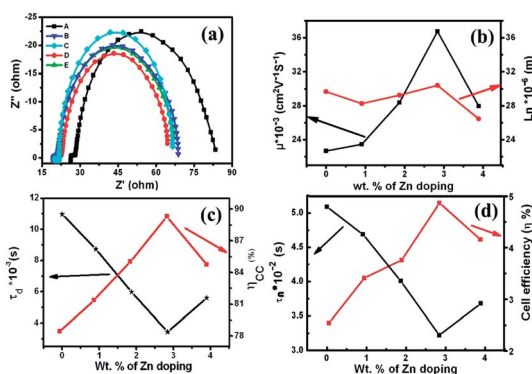


Fig. 4 (a) Nyquist plots, dependence of (b) electron mobility and diffusion length, (c) charge collection efficiency and transit time and (d) electron life time and cell efficiency with Zn-doping.

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